



# 1200V Dual Silicon Carbide Power module

## GE12047BCA3

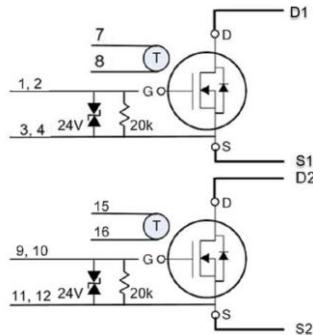
**V<sub>DS</sub>: 1200V I<sub>DS</sub>: 475A**

Superior performance for high power, high frequency applications needing best-in-class power density



## Features

- Highly reliable GE SiC MOSFET devices
- Low R<sub>DS(ON)</sub> (3.1 mΩ) (device only)
- Low stray inductance (1 nH)
- SiC die qualified to +200 °C
- Ultra-low switching losses over entire operating range
- Body diode with minimal reverse recovery
- Integrated temperature sensing
- Dedicated DESAT Pin and Source-Kelvin Pin
- AlSiC Baseplate and Si<sub>3</sub>N<sub>4</sub> AMB Substrate



**MOSFET DC Characteristics @ T<sub>J</sub> = 25 °C (unless otherwise specified)**

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
I <sub>D</sub>	Continuous Drain Current		475			V <sub>GS</sub> =20 V, T <sub>c</sub> =25 °C	
			333	A		V <sub>GS</sub> =20 V, T <sub>c</sub> =100 °C	Per Switch
			272			V <sub>GS</sub> =20 V, T <sub>c</sub> =125 °C	
I <sub>D,pulse</sub>	Pulsed Drain Current		950	A		T <sub>c</sub> =25 °C, t <sub>p</sub> =1 ms	
V <sub>DSmax</sub>	Drain - Source Breakdown Voltage	1200			V	V <sub>GS</sub> =0 V, I <sub>DS</sub> =100 μA	
V <sub>GSmax</sub>	Maximum Gate - Source Voltage		-15/+23		V	V <sub>DS</sub> =0 V	
V <sub>GSp</sub>	Recommended Gate - Source Voltage		-5/+20		V		
T <sub>Jmax</sub>	Junction Temperature		175		°C		
T <sub>C</sub>	Case Temperature Range	-55	150		°C		
T <sub>STG</sub>	Storage Temperature Range	-55	150		°C		
P <sub>D</sub>	Power Dissipation		1250	W		T <sub>c</sub> =25 °C	



(Continued) MOSFET DC Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$I_D$	Continuous Drain Current			475	A	$V_{GS}=20\text{ V}$ , $T_c=25^\circ\text{C}$	Per Switch
$V_{GS(th)}$	Gate Threshold Voltage	2.5	2.8	4.5	V	$V_{GS}=V_{DS}$ , $I_{DS}=160\text{ mA}$	
$I_{DSS}$	Drain Leakage Current			0.10	mA	$V_{DS}=1200\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=25^\circ\text{C}$	
				1.6		$T_J=200^\circ\text{C}$	
$I_{GSS}$	Gate-Source Leakage Current			160	nA	$V_{GS}=-15/+23\text{ V}$	
$R_{DS(on)}$	On State Resistance (Device Only)		3.1	4.4	mΩ	$V_{GS}=20\text{ V}$ , $I_{DS}=475\text{ A}$ , $T_J=25^\circ\text{C}$	Per Switch
			5.6	6.8		$T_J=175^\circ\text{C}$	
$R_{G(int)}$	Gate-Source series resistance		0.90		Ω	$V_{GS}=0\text{ V}$ , $f=100\text{ kHz}$ , $T_c=25^\circ\text{C}$	

MOSFET Dynamic Characteristics per switch @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$C_{iss}$	Input Capacitance		29.3		nF		
$C_{oss}$	Output Capacitance		1.60		nF	$V_{GS}=0\text{ V}$ $V_{DS}=600\text{ V}$ $f=100\text{ kHz}$	
$C_{rss}$	Reverse Transfer Capacitance		0.13		nF		
$E_{on}$	Turn-On Switching Energy		7.72		mJ		
$E_{off}$	Turn-Off Switching Energy		3.79		mJ	$V_{GS}=0\text{ V}$ to $+20\text{ V}$ $V_{DS}=800\text{ V}$ $I_{DS}=350\text{ A}$ $R_{G(ext)}=0\text{ Ω}$	Tested in half-bridge configuration
$t_r$	Rise Time		21.9		ns		
$t_f$	Fall Time		38.9		ns		
$Q_G$	Total Gate Charge		1248		nC		
$Q_{GD}$	Gate-Drain Charge		536		nC	$V_{GS}=0$ to $18\text{ V}$ $V_{DS}=900\text{ V}$ $I_{DS}=240\text{ A}$	
$Q_{GS}$	Gate-Source Charge		176		nC		

Body Diode Characteristics per switch @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$I_{SD}$	Pulsed body diode current			720	A	$V_{GS}=0\text{ V}$	1.
$V_{SD}$	Diode Forward Voltage		4.69		V	$V_{GS}=0\text{ V}$ , $I_{SD}=475\text{ A}$ , $T_J=25^\circ\text{C}$	

1. Use of body diode is recommended in pulse mode only, with pulse duration up to  $1\mu\text{s}$

Thermal Characteristics

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$R_{th}$	Thermal Resistance Junction-to-Case		0.10	0.12	°C/W	JESD24-3	Per Switch



## Temperature Sensor Characteristics

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$R_{RTD}$	Rated Resistance of RTD		1k		ohm		2.
	Tolerance of Resistance		0.12		%		
	Accuracy		0.3		°C		
	Measuring Current	100		300	µA		
TCR	Temperature Coefficient		3850		ppm/K		
	Operating Temperature	-70		+500	°C		
	Insulation Resistance	100			Mohm	20 °C	

2. RTD is mounted directly over center-most die allowing direct reading of  $T_J$

## Module packaging data

Symbols	Parameters	Min.	Typ.	Max.	Unit	Test Conditions	Notes
$V_{ISO}$	Case Isolation Voltage	4			kV	AC 50Hz, 1min, 25 °C	
CTI	Comparative Tracking Index		600				
$M_s$	Mounting Torque			5.0	N-m	Power Terminals	
				4.0		Baseplate	
$L_{D1S1}$	Loop Inductance	1		nH			
$L_{D2S2}$	Loop Inductance	1		nH			
	Module Mass	0.12		kg			
		9		mm		D1 to D2	
		4		mm		D1 to S1	
	Clearance Distance	23		mm		Pins 1, 2 to S1	
		25		mm		Pins 9, 10 to S1	
		9		mm		D1, S2 to Baseplate	
		12		mm		Pins 7, 8 to Baseplate	
	Creepage Distance	11		mm		D1 to D2	
		6		mm		D1 to S1	
		28		mm		Pins 1, 2 to S1	
		30		mm		Pins 9, 10 to S1	
		12		mm		D1, S2 to Baseplate	
		17		mm		Pins 7, 8 to Baseplate	
$M_{BP}$	Base Plate Material			AlSiC			



Typical performance: GE12047BCA3

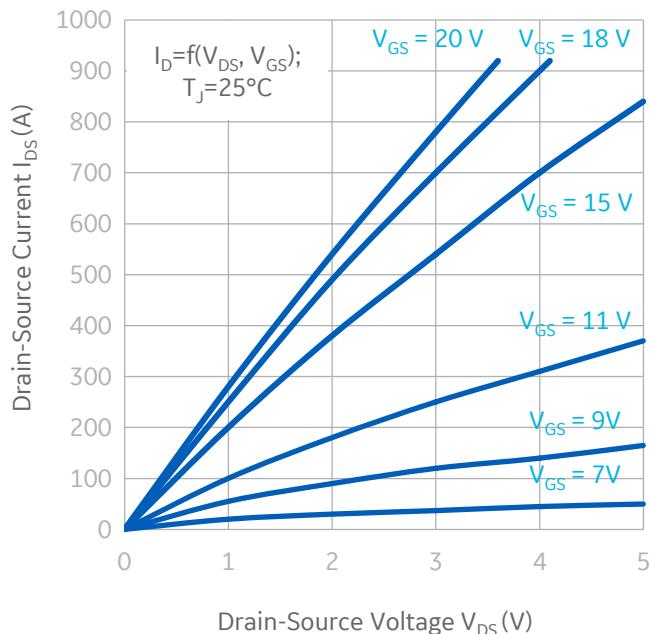


Figure 1: Output characteristics ( $25^\circ\text{C}$ )

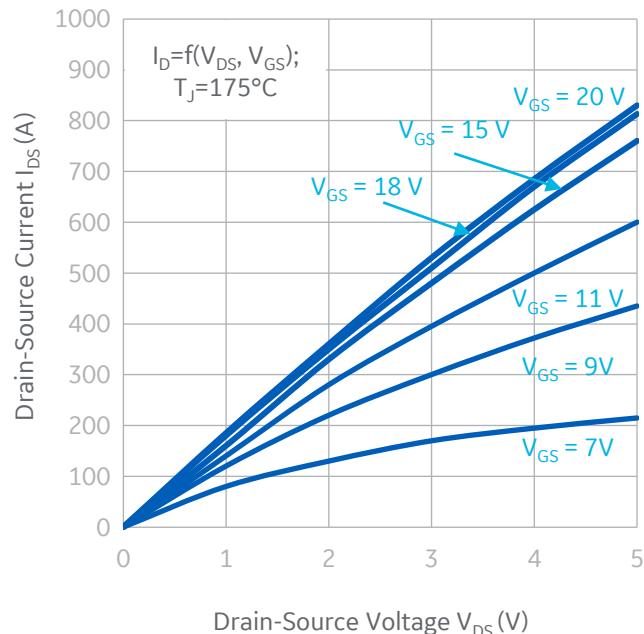


Figure 2: Output characteristics ( $175^\circ\text{C}$ )

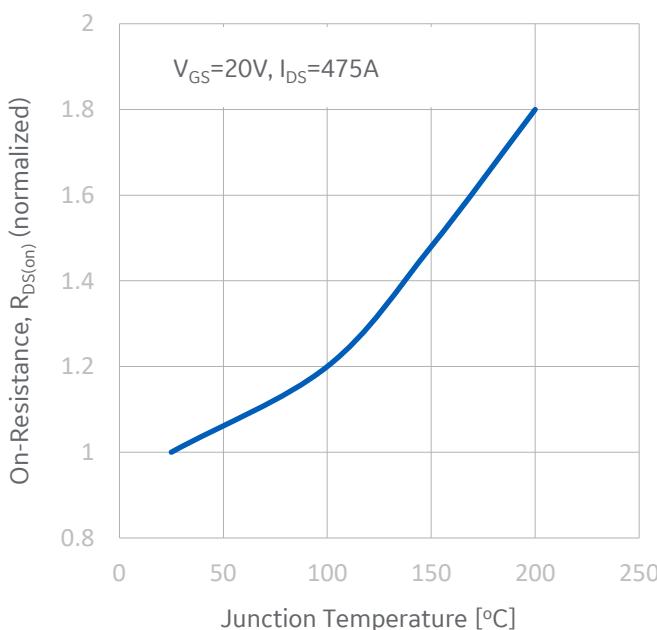


Figure 3: Normalized on-state resistance vs Temperature

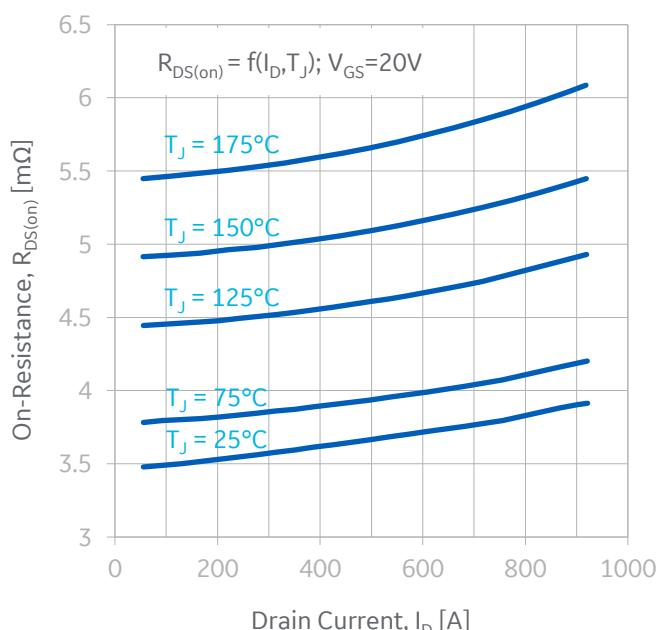


Figure 4: Module Drain-Source on-state resistance



Typical performance: GE12047BCA3

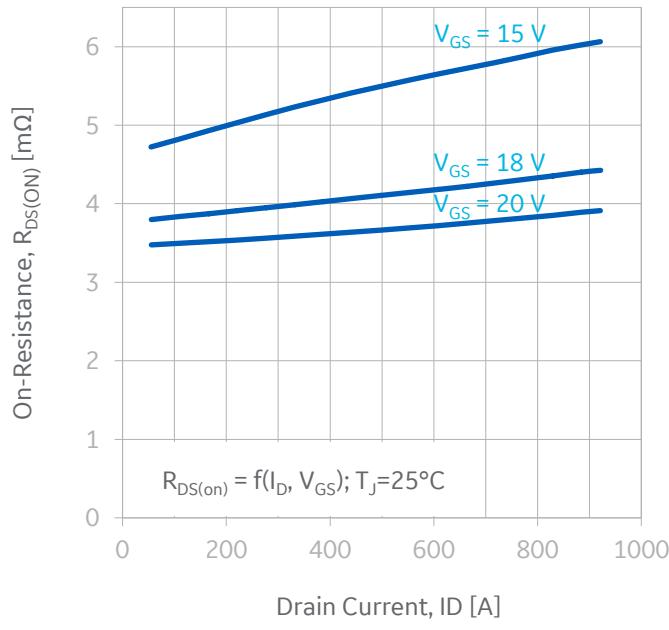


Figure 5: Module Drain-Source on-state resistance

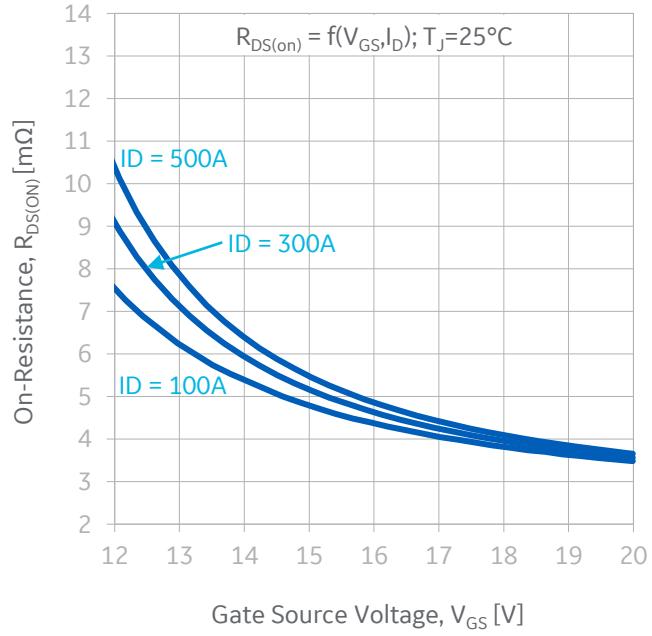


Figure 6: Drain-Source on-state resistance vs. Gate-Source Voltage

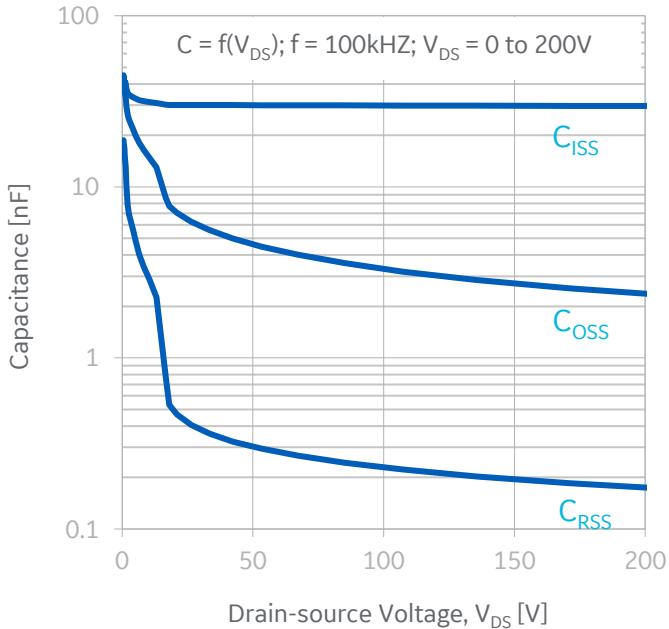


Figure 7: Input Capacitance to 200V

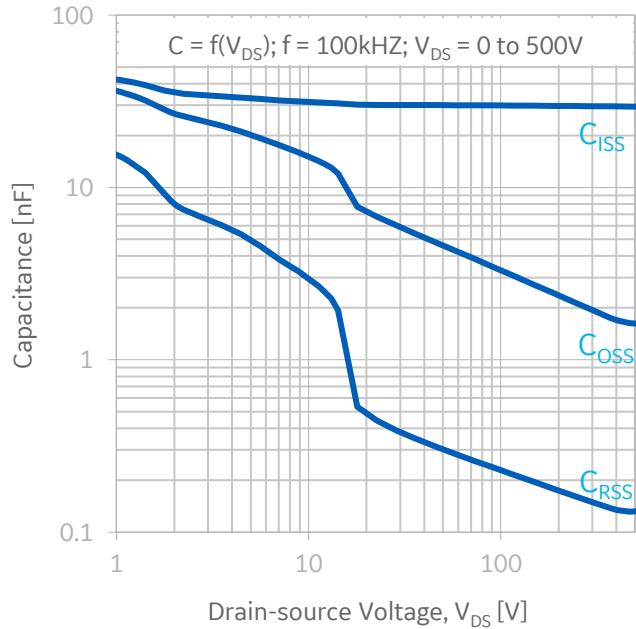


Figure 8: Input Capacitance to 500V



Typical performance: GE12047BCA3

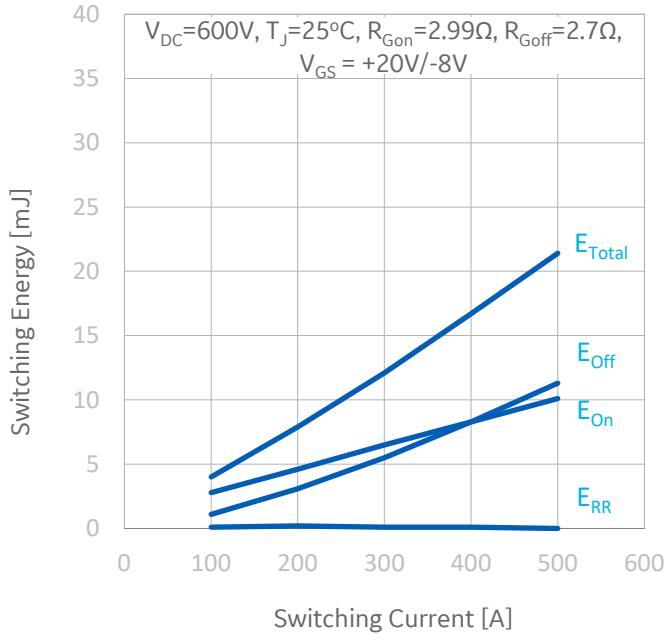


Figure 9: Switching Energy Vs Drain Current (600V)

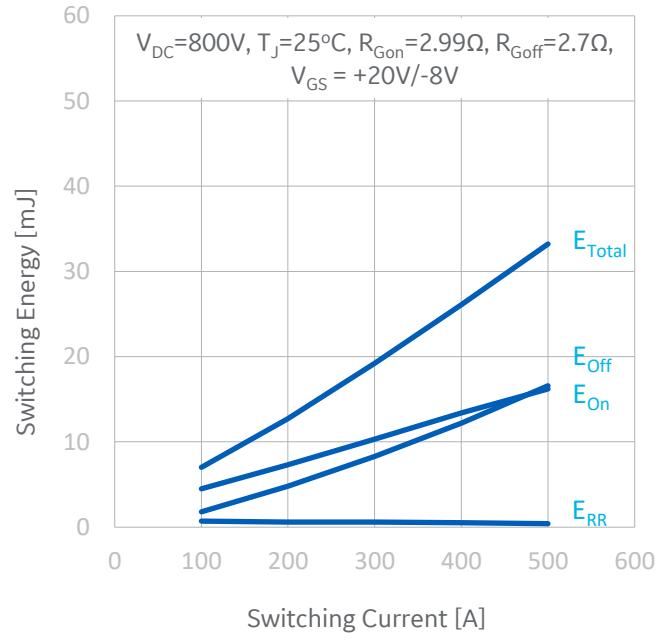


Figure 10: Switching Energy Vs Drain Current (800V)

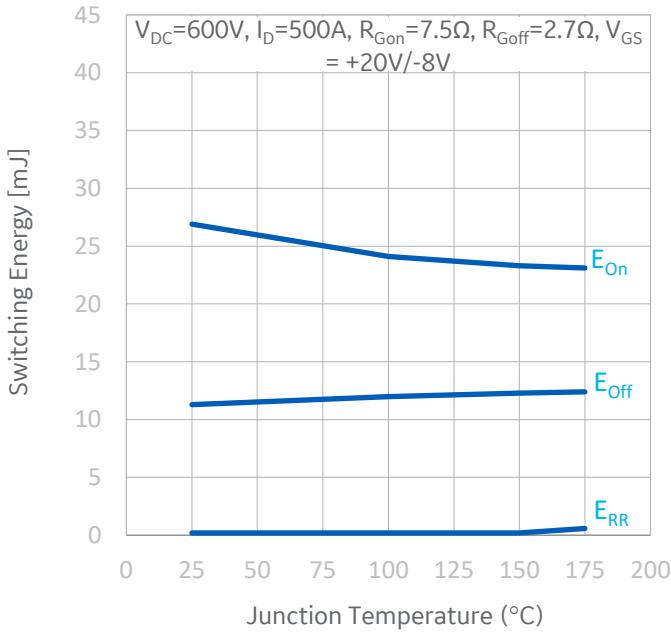


Figure 11: Switching Energy Vs Junction Temperature

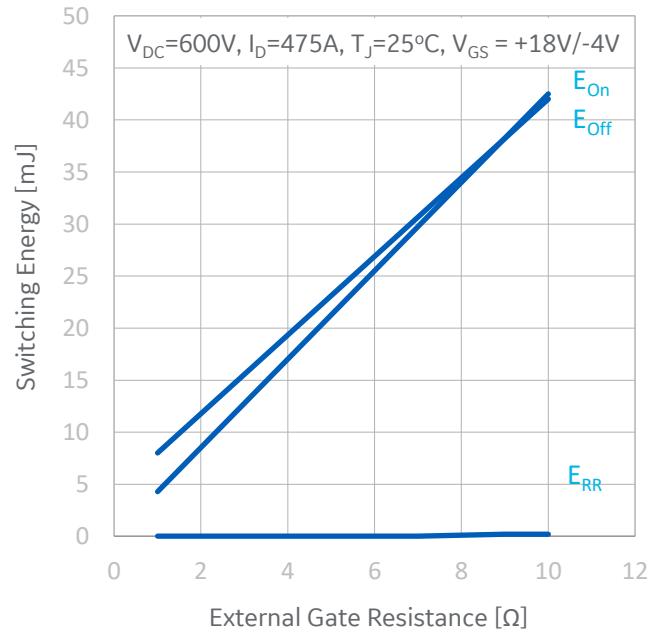
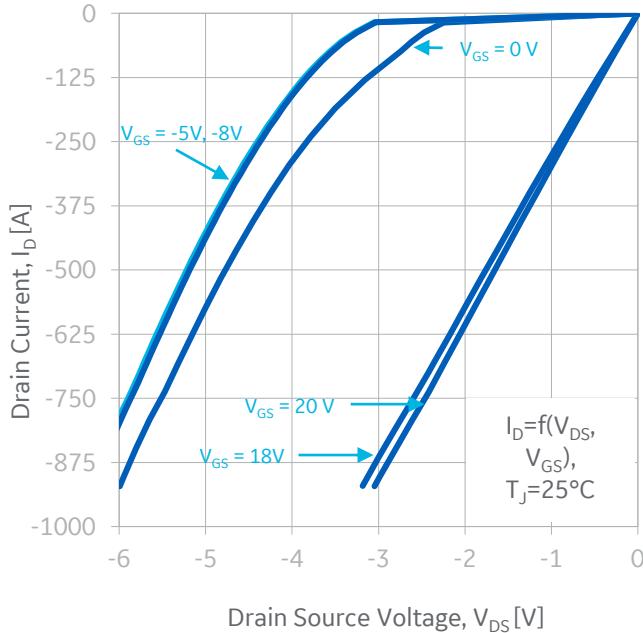


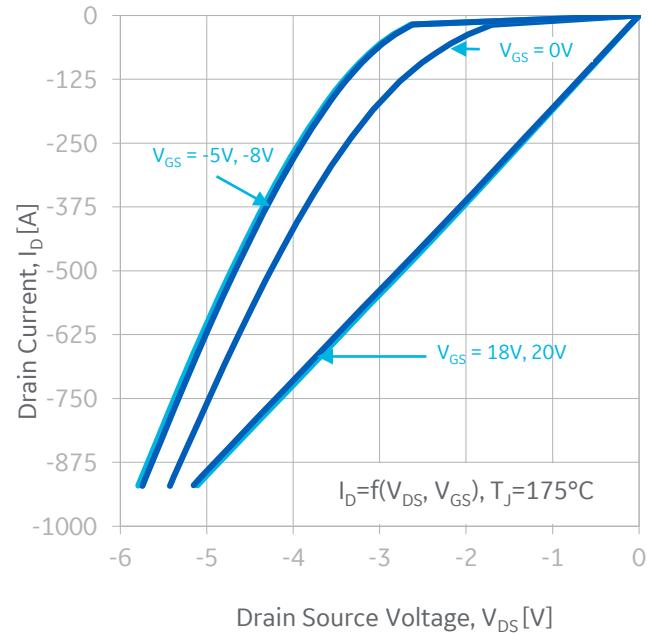
Figure 12: Switching Energy Vs Gate Resistance



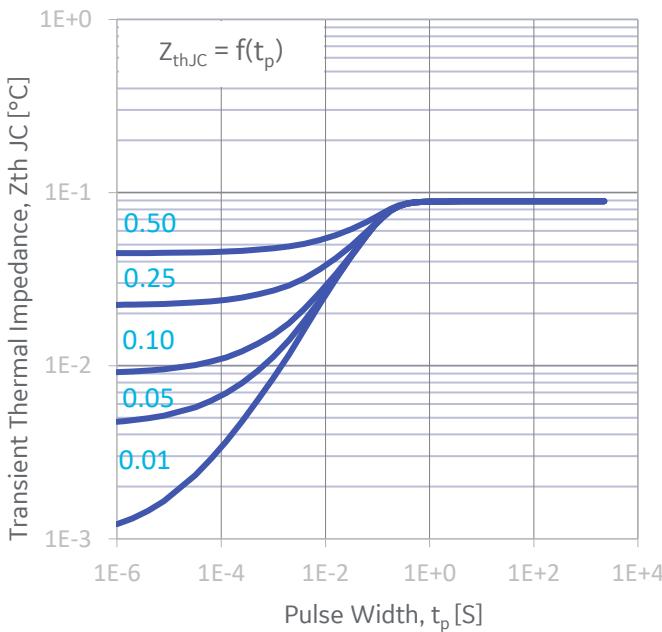
Typical performance: GE12047BCA3



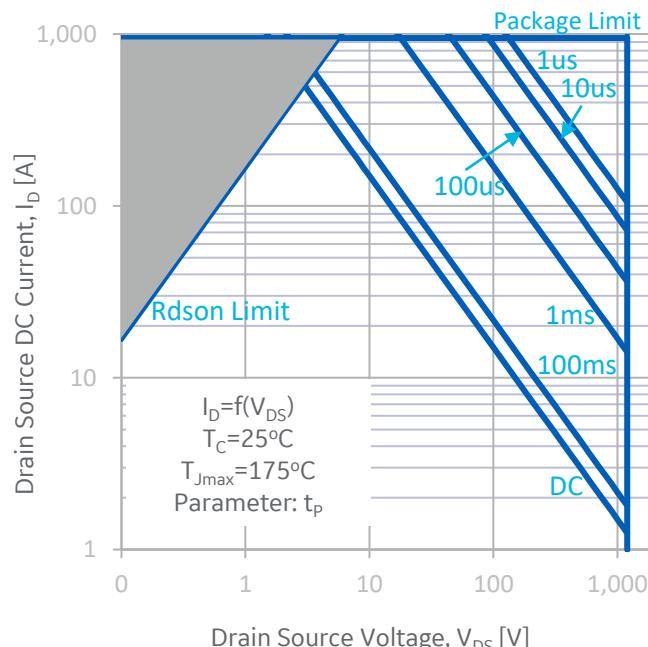
**Figure 13:** 3<sup>rd</sup> Quadrant Characteristics (25°C)



**Figure 14:** 3<sup>rd</sup> Quadrant Characteristics (175°C)



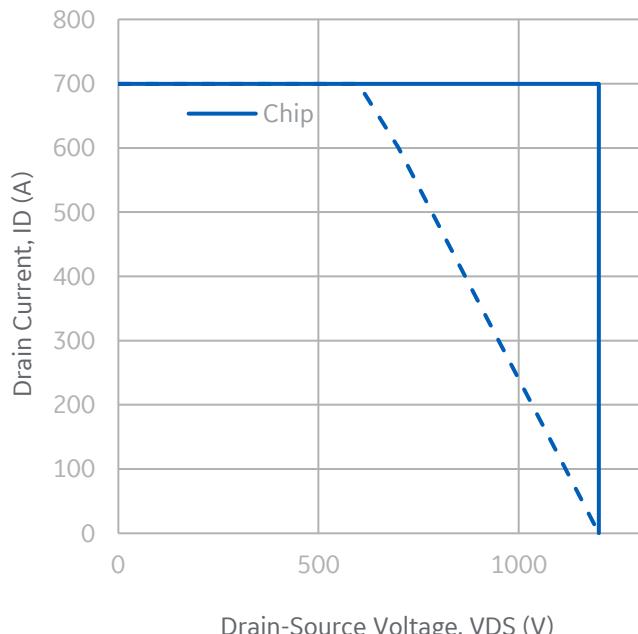
**Figure 15:** Transient Thermal Impedance



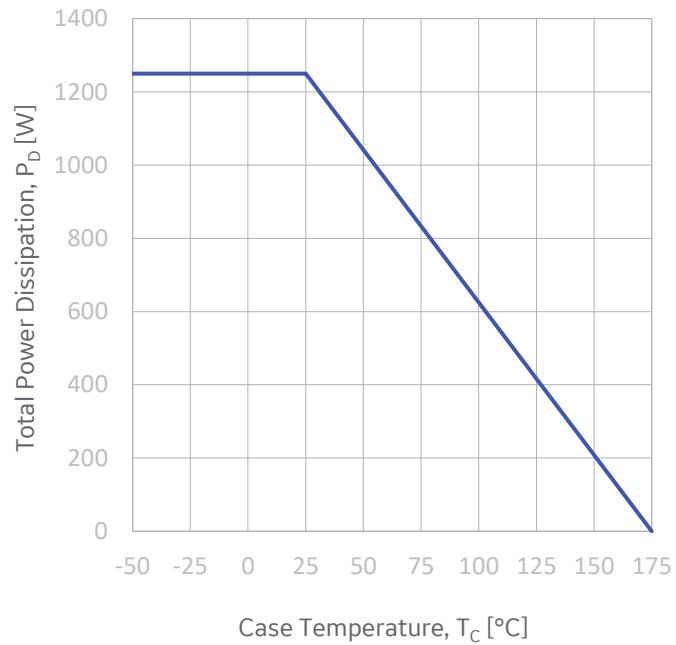
**Figure 16:** Forward-Bias Safe Operating Area



Typical performance: **GE12047BCA3**



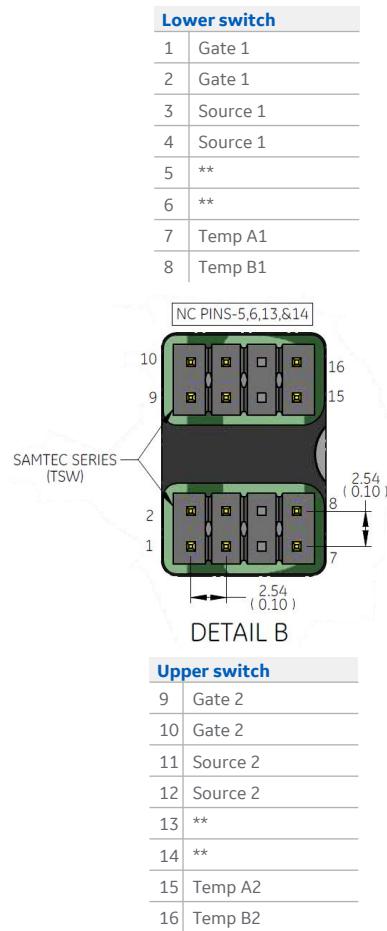
**Figure 17:** Reverse-Bias Safe Operating Area



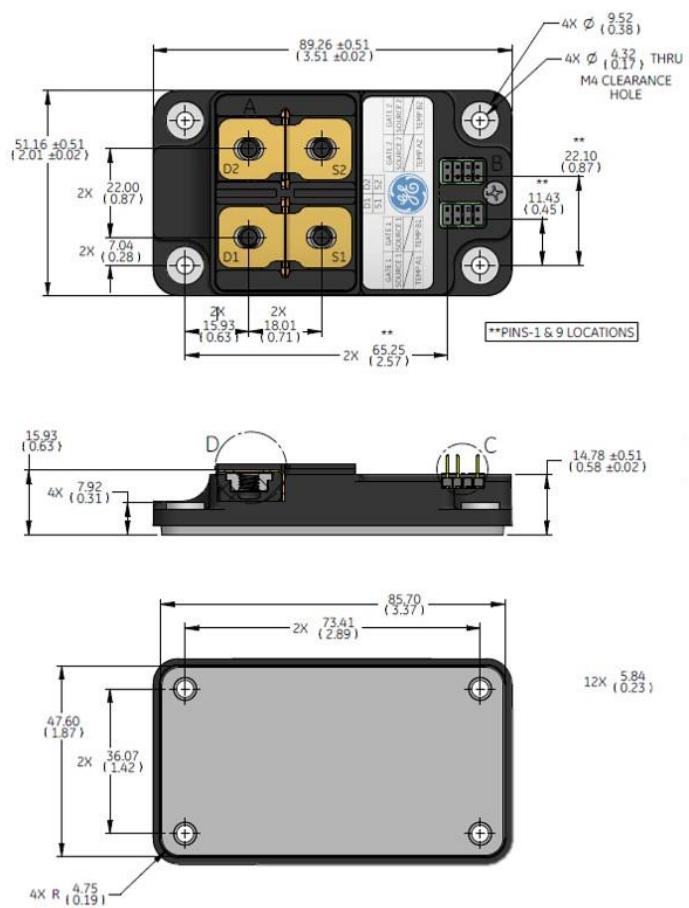
**Figure 18:** Maximum Power Dissipation Vs Case Temperature



## Electrical interface outline drawing



## Module dimensions (millimeters)



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### Document revisions

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